


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/871,571	DENEIRE ET AL.	
	Examiner	Art Unit	
	Man Phan	2665	

SEARCHED			
Class	Subclass	Date	Examiner
370	203-210	7/6/2005	MP
	341-345		
	480-503		
375	219-222		
	260-296		
	340-343		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	203	7/9/2005	MP
	252		
375	224		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST/WEST search (search 370, 375 classes)	7/6/2005	MP